

Search Notes

Application/Control No.

10/761,297

Examiner

Sisay Yacob

Applicant(s)/Patent under
Reexamination

SUN, BEN-CHANG

Art Unit

2612

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|----------|----------|
| 341 | 22 | 2/9/2007 | S.Y. |
| 341 | 23, 26 | 2/9/2007 | S.Y. |
| 341 | 34 | 2/9/2007 | S.Y. |
| 345 | 172 | 2/9/2007 | S.Y. |
| 345 | 171, 173 | 2/9/2007 | S.Y. |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|----------|------|
| Searched EAST: US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB | 2/9/2007 | S.Y. |
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